

**Search Notes****Application/Control No.**

10/561,980

**Examiner**

Jean F. Duverne

**Applicant(s)/Patent under Reexamination**

MIKUBO ET AL.

**Art Unit**

2839

**SEARCHED**

Class	Subclass	Date	Examiner
361	699	4/28/2007	JFD
	695-698		
	687-692		
	701-703	4/28/2007	JFD

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner